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December 2014

# FCP260N60E / FCPF260N60E

## N-Channel SuperFET<sup>®</sup> II Easy-Drive MOSFET

600 V, 15 A, 260 mΩ



### Features

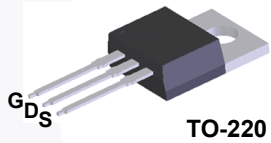
- 650 V @  $T_J = 150^\circ\text{C}$
- Typ.  $R_{DS(on)} = 220\text{ m}\Omega$
- Ultra Low Gate Charge (Typ.  $Q_g = 48\text{ nC}$ )
- Low Effective Output Capacitance (Typ.  $C_{oss(eff.)} = 129\text{ pF}$ )
- 100% Avalanche Tested
- An Integrated Gate Resistor
- RoHS Compliant

### Description

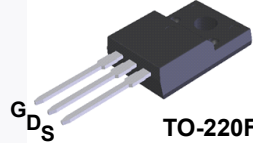
SuperFET<sup>®</sup> II MOSFET is Fairchild Semiconductor's brand-new high voltage super-junction (SJ) MOSFET family that is utilizing charge balance technology for outstanding low on-resistance and lower gate charge performance. This technology is tailored to minimize conduction loss, provide superior switching performance,  $dv/dt$  rate and higher avalanche energy. Consequently, SuperFET II MOSFET easy-drive series offers slightly slower rise and fall times compared to the SuperFET II MOSFET series. Noted by the "E" part number suffix, this family helps manage EMI issues and allows for easier design implementation. For faster switching in applications where switching losses must be at an absolute minimum, please consider the SuperFET II MOSFET series.

### Applications

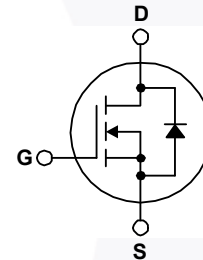
- LCD / LED / PDP TV Lighting
- Solar Inverter
- AC-DC Power Supply



TO-220



TO-220F



### MOSFET Maximum Ratings $T_C = 25^\circ\text{C}$ unless otherwise noted.

Symbol	Parameter	FCP260N60E	FCPF260N60E	Unit
$V_{DSS}$	Drain to Source Voltage	600		V
$V_{GSS}$	Gate to Source Voltage	- DC	$\pm 20$	V
		- AC ( $f > 1\text{ Hz}$ )	$\pm 30$	V
$I_D$	Drain Current	- Continuous ( $T_C = 25^\circ\text{C}$ )	15	15*
		- Continuous ( $T_C = 100^\circ\text{C}$ )	9.5	9.5*
$I_{DM}$	Drain Current	- Pulsed (Note 1)	45	45*
$E_{AS}$	Single Pulsed Avalanche Energy (Note 2)	292.5		mJ
$I_{AR}$	Avalanche Current (Note 1)	3.0		A
$E_{AR}$	Repetitive Avalanche Energy (Note 1)	1.56		mJ
$dv/dt$	MOSFET $dv/dt$	100		V/ns
	Peak Diode Recovery $dv/dt$ (Note 3)	20		
$P_D$	Power Dissipation	( $T_C = 25^\circ\text{C}$ )	156	36
		- Derate Above $25^\circ\text{C}$	1.25	0.29
$T_J, T_{STG}$	Operating and Storage Temperature Range	-55 to +150		$^\circ\text{C}$
$T_L$	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds	300		$^\circ\text{C}$

\*Drain current limited by maximum junction temperature.

### Thermal Characteristics

Symbol	Parameter	FCP260N60E	FCPF260N60E	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case, Max.	0.8	3.5	$^\circ\text{C}/\text{W}$
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient, Max.	62.5	62.5	

FCP260N60E / FCPF260N60E — N-Channel SuperFET<sup>®</sup> II Easy-Drive MOSFET

## Package Marking and Ordering Information

Part Number	Top Mark	Package	Packing Method	Reel Size	Tape Width	Quantity
FCP260N60E	FCP260N60E	TO-220	Tube	N/A	N/A	50 units
FCPF260N60E	FCPF260N60E	TO-220F	Tube	N/A	N/A	50 units

## Electrical Characteristics $T_C = 25^\circ\text{C}$ unless otherwise noted.

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
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### Off Characteristics

$BV_{DSS}$	Drain to Source Breakdown Voltage	$V_{GS} = 0\text{ V}, I_D = 10\text{ mA}, T_J = 25^\circ\text{C}$	600	-	-	V
		$V_{GS} = 0\text{ V}, I_D = 10\text{ mA}, T_J = 150^\circ\text{C}$	650	-	-	
$\Delta BV_{DSS} / \Delta T_J$	Breakdown Voltage Temperature Coefficient	$I_D = 10\text{ mA}$ , Referenced to $25^\circ\text{C}$	-	0.67	-	$V/^\circ\text{C}$
$BV_{DS}$	Drain to Source Avalanche Breakdown Voltage	$V_{GS} = 0\text{ V}, I_D = 15\text{ A}$	-	700	-	V
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = 600\text{ V}, V_{GS} = 0\text{ V}$	-	-	1	$\mu\text{A}$
		$V_{DS} = 480\text{ V}, T_C = 125^\circ\text{C}$	-	2.6	-	
$I_{GSS}$	Gate to Body Leakage Current	$V_{GS} = \pm 20\text{ V}, V_{DS} = 0\text{ V}$	-	-	$\pm 100$	nA

### On Characteristics

$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250\ \mu\text{A}$	2.5	-	3.5	V
$R_{DS(on)}$	Static Drain to Source On Resistance	$V_{GS} = 10\text{ V}, I_D = 7.5\text{ A}$	-	0.22	0.26	$\Omega$
$g_{FS}$	Forward Transconductance	$V_{DS} = 20\text{ V}, I_D = 7.5\text{ A}$	-	15.5	-	S

### Dynamic Characteristics

$C_{iss}$	Input Capacitance	$V_{DS} = 25\text{ V}, V_{GS} = 0\text{ V}, f = 1\text{ MHz}$	-	1880	2500	pF
$C_{oss}$	Output Capacitance		-	1330	1770	pF
$C_{riss}$	Reverse Transfer Capacitance		-	85	130	pF
$C_{oss}$	Output Capacitance	$V_{DS} = 380\text{ V}, V_{GS} = 0\text{ V}, f = 1\text{ MHz}$	-	32	-	pF
$C_{oss(eff.)}$	Effective Output Capacitance	$V_{DS} = 0\text{ V to } 480\text{ V}, V_{GS} = 0\text{ V}$	-	129	-	pF
$Q_{g(tot)}$	Total Gate Charge at 10V	$V_{DS} = 380\text{ V}, I_D = 7.5\text{ A}, V_{GS} = 10\text{ V}$	-	48	62	nC
$Q_{gs}$	Gate to Source Gate Charge		-	7.4	-	nC
$Q_{gd}$	Gate to Drain "Miller" Charge		(Note 4)	-	17	-
ESR	Equivalent Series Resistance	$f = 1\text{ MHz}$	-	5.8	-	$\Omega$

### Switching Characteristics

$t_{d(on)}$	Turn-On Delay Time	$V_{DD} = 380\text{ V}, I_D = 7.5\text{ A}, V_{GS} = 10\text{ V}, R_G = 4.7\ \Omega$	-	20	50	ns
$t_r$	Turn-On Rise Time		-	11	32	ns
$t_{d(off)}$	Turn-Off Delay Time		-	89	188	ns
$t_f$	Turn-Off Fall Time		(Note 4)	-	13	36

### Drain-Source Diode Characteristics

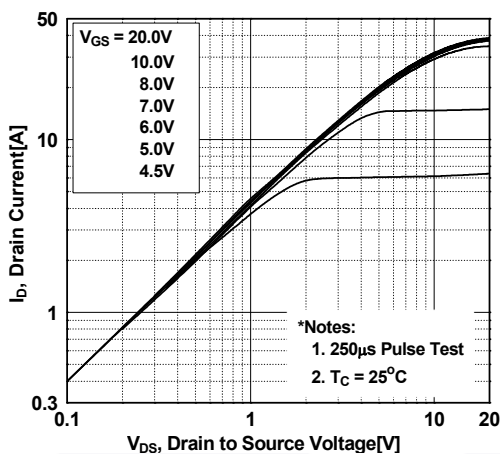
$I_S$	Maximum Continuous Drain to Source Diode Forward Current	-	-	15	A	
$I_{SM}$	Maximum Pulsed Drain to Source Diode Forward Current	-	-	45	A	
$V_{SD}$	Drain to Source Diode Forward Voltage	$V_{GS} = 0\text{ V}, I_{SD} = 7.5\text{ A}$	-	-	1.2	V
$t_{rr}$	Reverse Recovery Time	$V_{GS} = 0\text{ V}, I_{SD} = 7.5\text{ A}$	-	270	-	ns
$Q_{rr}$	Reverse Recovery Charge	$di_F/dt = 100\text{ A}/\mu\text{s}$	-	3.6	-	$\mu\text{C}$

#### Notes:

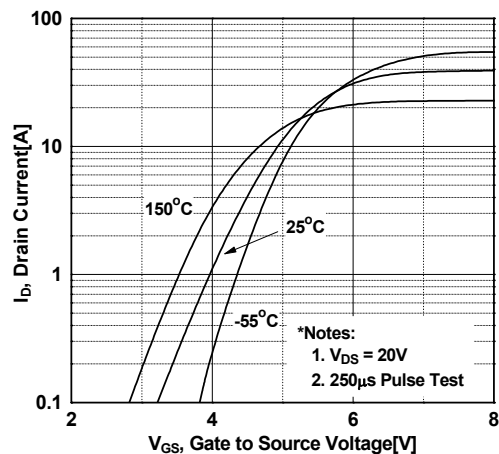
1. Repetitive rating : pulse-width limited by maximum junction temperature.
2.  $I_{AS} = 3\text{ A}, V_{DD} = 50\text{ V}, R_G = 25\ \Omega$ , starting  $T_J = 25^\circ\text{C}$ .
3.  $I_{SD} \leq 7.5\text{ A}, di/dt \leq 200\text{ A}/\mu\text{s}, V_{DD} \leq BV_{DSS}$ , starting  $T_J = 25^\circ\text{C}$ .
4. Essentially independent of operating temperature typical characteristics.

## Typical Performance Characteristics

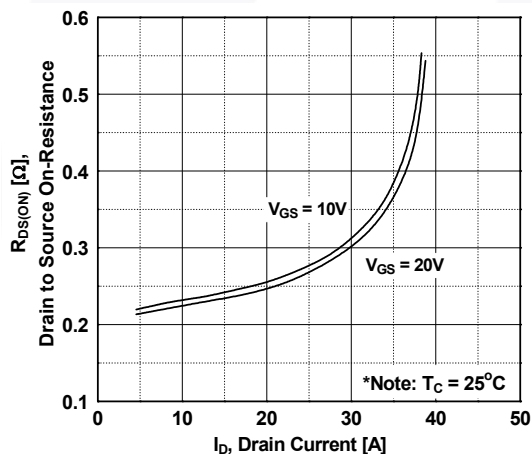
**Figure 1. On-Region Characteristics**



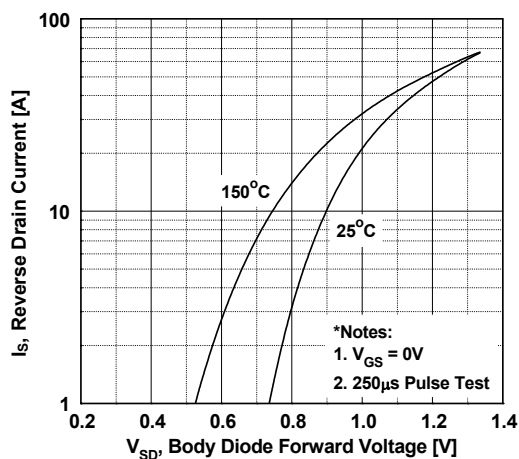
**Figure 2. Transfer Characteristics**



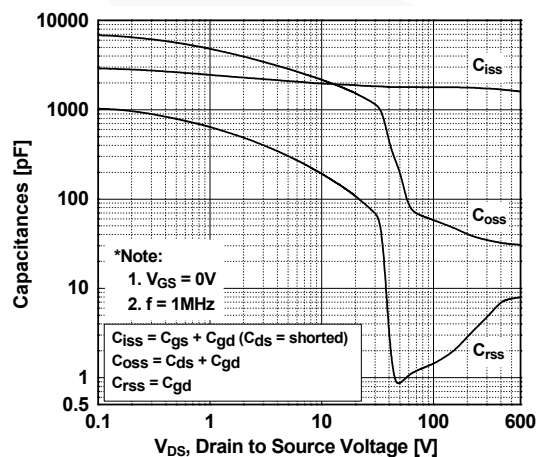
**Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage**



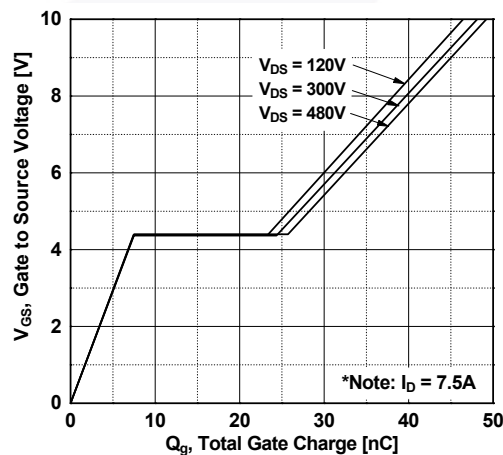
**Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature**



**Figure 5. Capacitance Characteristics**

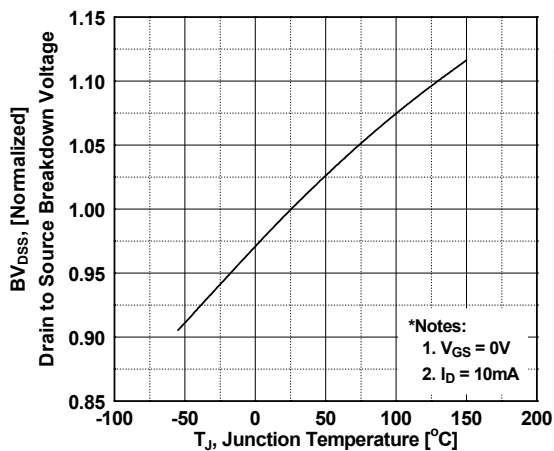


**Figure 6. Gate Charge Characteristics**

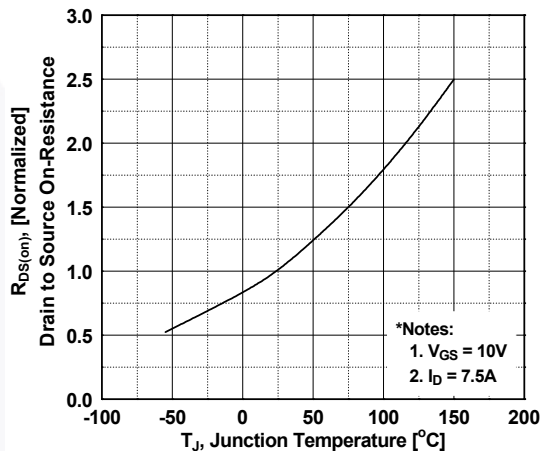


**Typical Performance Characteristics** (Continued)

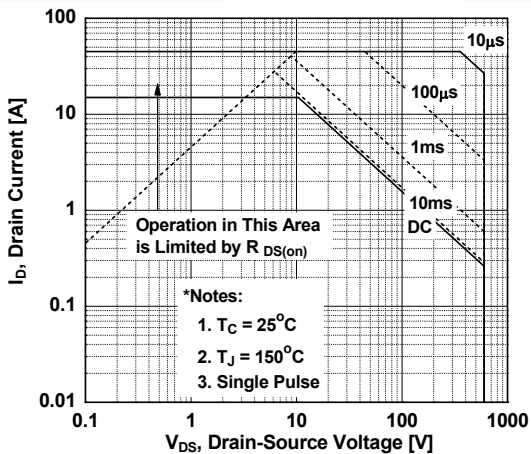
**Figure 7. Breakdown Voltage Variation vs. Temperature**



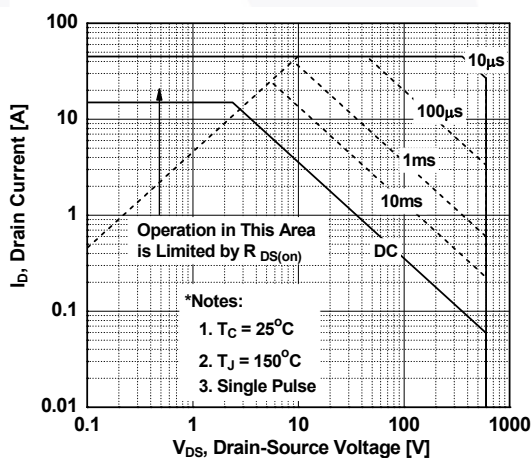
**Figure 8. On-Resistance Variation vs. Temperature**



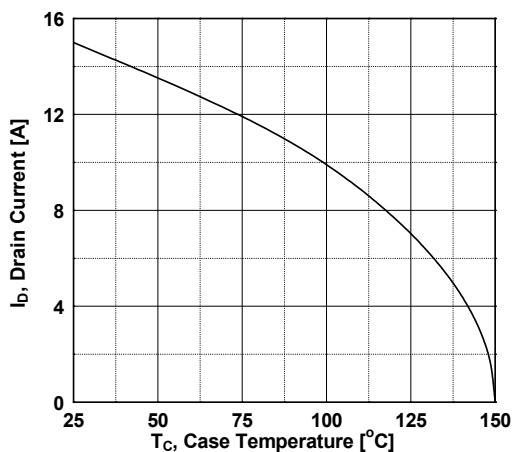
**Figure 9. Maximum Safe Operating Area for FCP260N60E**



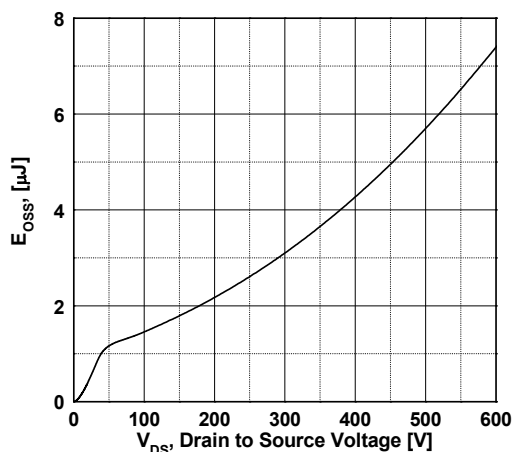
**Figure 10. Maximum Safe Operating Area for FCPF260N60E**



**Figure 11. Maximum Drain Current vs. Case Temperature**



**Figure 12. E\_oss vs. Drain to Source Voltage**



Typical Performance Characteristics (Continued)

Figure 13. Transient Thermal Response Curve for FCP260N60E

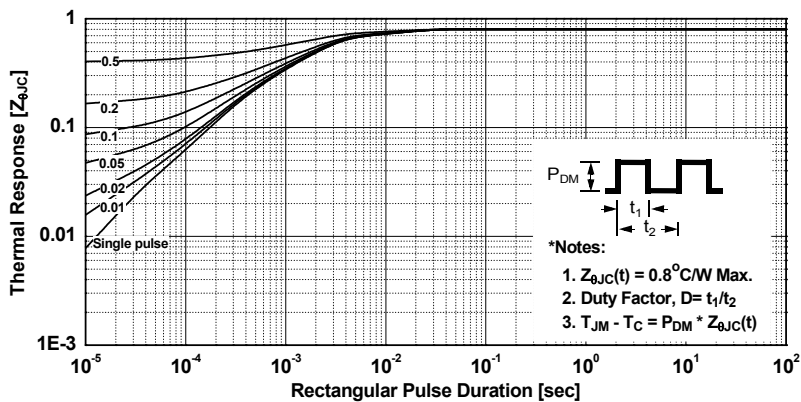
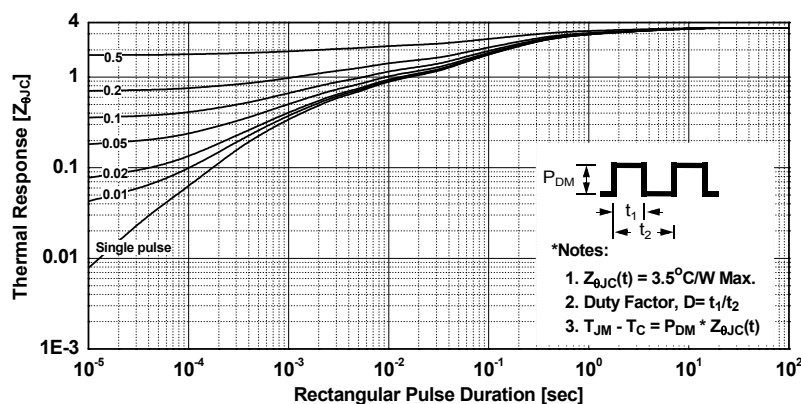
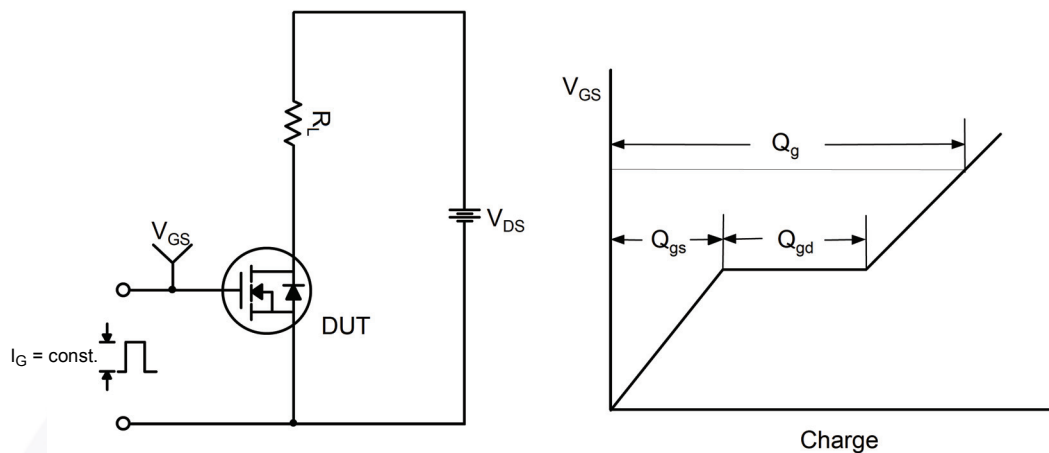
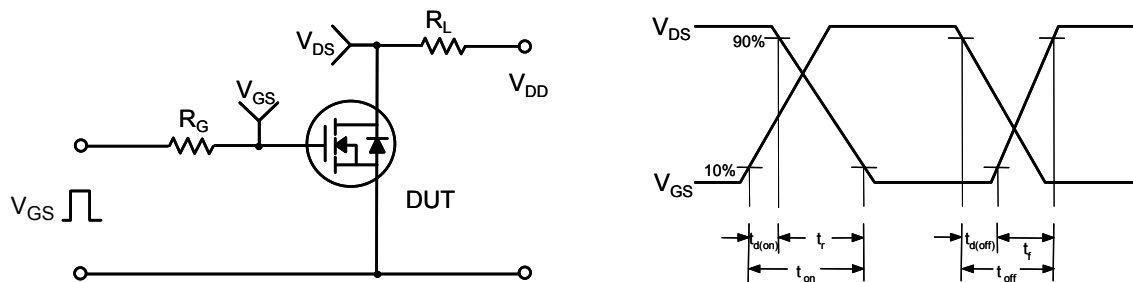


Figure 14. Transient Thermal Response Curve for FCPF260N60E

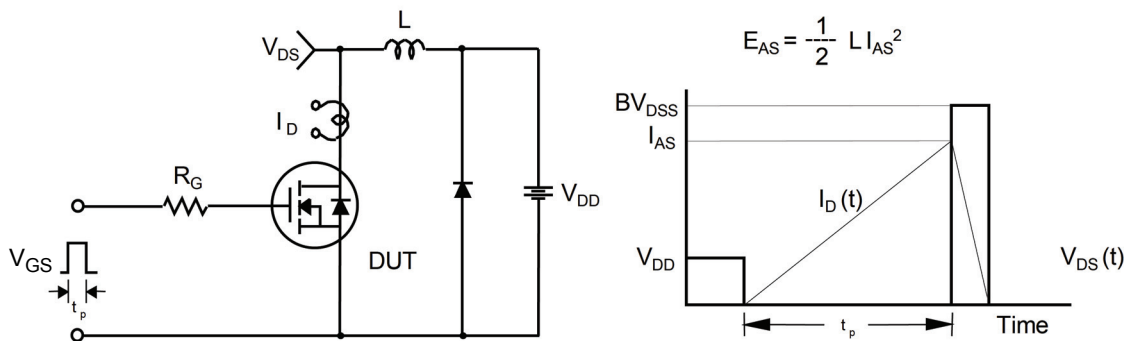




**Figure 15. Gate Charge Test Circuit & Waveform**



**Figure 16. Resistive Switching Test Circuit & Waveforms**



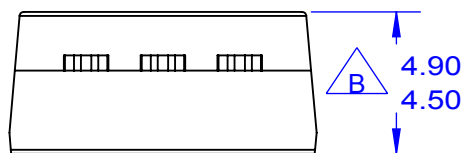
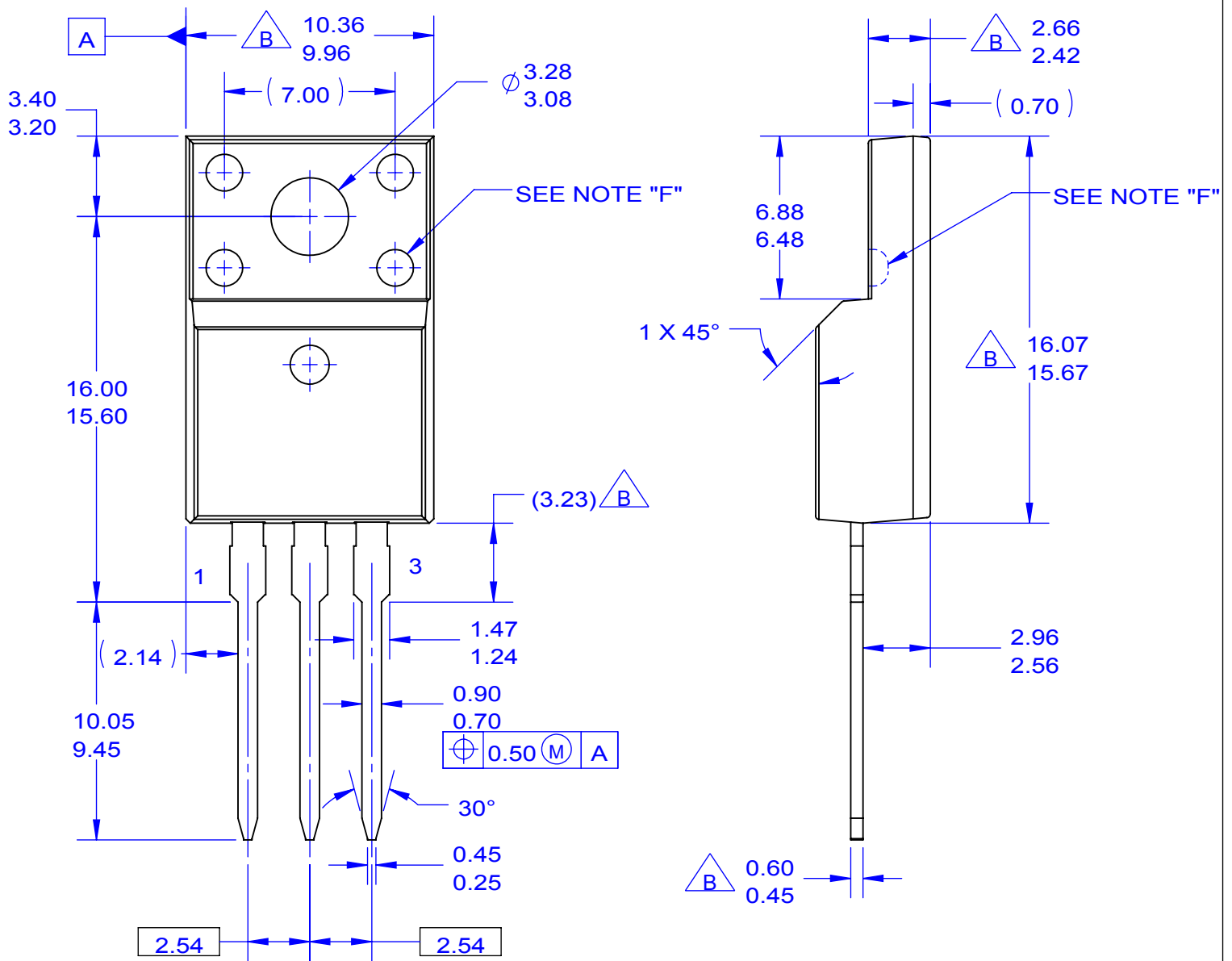
**Figure 17. Unclamped Inductive Switching Test Circuit & Waveforms**



Figure 18. Peak Diode Recovery  $dv/dt$  Test Circuit & Waveforms







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NOTES:

- A. EXCEPT WHERE NOTED CONFORMS TO EIAJ SC91A.
- B. DOES NOT COMPLY EIAJ STD. VALUE.
- C. ALL DIMENSIONS ARE IN MILLIMETERS.
- D. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR PROTRUSIONS.
- E. DIMENSION AND TOLERANCE AS PER ASME Y14.5-1994.
- F. OPTION 1 - WITH SUPPORT PIN HOLE.  
OPTION 2 - NO SUPPORT PIN HOLE.
- G. DRAWING FILE NAME: TO220M03REV5

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